

**Search Notes**

Application/Control No.

10/757,405

Examiner

David E. Martinez

Applicant(s)/Patent under  
Reexamination

TAKINOSAWA ET AL.

Art Unit

2182

**SEARCHED**

Class	Subclass	Date	Examiner
710	/2,62,72,1 00,300,30 1,305,313	12/15/2005	DM

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East - See Attached	12/15/2005	DM
Inventor Search eDan	12/15/2005	DM
Databases: US Patents, US PGPUBS, USOCR, EPO, Derwent, IBM_TDB.	12/15/2005	DM